Film thickness effect on structure and optical properties of nanostructured ZnS thin films deposited by spray technique



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Abstract

In this work, the sprayed ZnS thin films were deposited on glass substrate at 400C° using ultrasonic spray chemical technique (SPC). The effect of film thickness on structure and optical properties of nanostructured ZnS thin films was investigated. From XRD analysis, it was observed that the prepared material has a hexagonal structure with good crystallinity. This finding was in a good agreement with the morphological properties in the SEM images. It was also found that the maximum crystallite size is 45.3nm, which was obtained with 577 nm film thickness. From optically experiments, ZnS thin films have a good transparency in visible region and the band gap energy of all deposit films was varied in the range 3.9-4.1eV.

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Introduction

Fig.2.

Based on latest researches, on the investigation of new material to be used in cell solar application, various materials composed of binary nanostructured semiconductor compounds, such as In₂O₃, ZnO, Cu₂O, SnO₂ and CdO, have been investigated for several applications. Naturally, ZnS, which belongs to II-VI compound semiconductors, has been under extensive research in recent years because of its wide technological applications. Among these material applications, ZnS has been employed in optoelectronic devices and piezoelectric fields. It has a high transparency and good conductivity, as well as chemical and mechanical stability. ZnS has been intensively studied as a promising material for cell solar because of its wide band gap (3.5-3.8eV) and high stability that are similar to ZnO ones.





4.0

4.5

0.2 🖗

600

transmittance of the thin films varied from 80% to 50%. \succ the band gap is between (4.09-3.99) eV. > the defects have been increased in the

greater film thickness leading to a decrease in the optical gap energy.

Conclusion

From XRD analysis, a hexagonal structure of ZnS with good crystallinity was confirmed.

≻The crystallite size maximum is 45.3 nm was obtained with 577 nm film thickness.

 \succ From optic measurements in visible region, ZnS thin films have a transparency of 50-80%, the band gap energy of all deposit films were varied in rang 3.9 to 4.1 eV. At lower film thickness, the ZnS thin films become less disorder and fewer defects.